

**Notice of References Cited**

Application/Control No.

10/029,769

Applicant(s)/Patent Under  
Reexamination  
RILEY ET AL.

Examiner

Tan Dean D. Nguyen

Art Unit

3689

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,546,017	04-2003	Khaunte, Sunil	370/412
	B	US-			
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**NON-PATENT DOCUMENTS**

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